

<b>Notice of References Cited</b>	Application/Control No. 10/550,237		Applicant(s)/Patent Under Reexamination MAARANEN ET AL.	
	Examiner RIP A. LEE		Art Unit 1796	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,767,208	06-1998	Turner et al.	526/160
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	F	US-			
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	J	US-			
	K	US-			
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	M	US-			

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*	N	WO 00/40620 A1	01-2000	International	Skar et al.	C08F 10/02
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